

# MSQ30P40D

## Dual P-Channel 30-V (D-S) MOSFET

### Description

The device is the highest performance trench P-ch MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The device meets the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

### Features

- $R_{DS(ON)} = 30m\Omega @ V_{GS} = -10V$
- $R_{DS(ON)} = 40m\Omega @ V_{GS} = -4.5V$
- Super Low Gate Charge
- Excellent  $CdV/dt$  effect decline
- 100% EAS Guaranteed
- Green Device Available

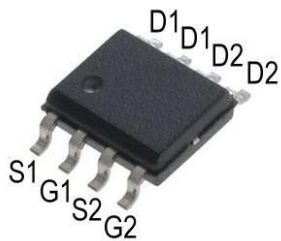
### Typical Applications

- MB / VGA / Vcore
- POL Applications
- Load Switch
- LED Applications

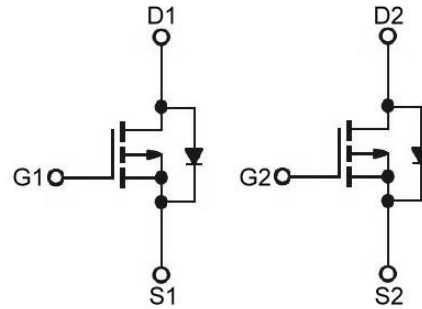
Package type : SOP-8

### Packing & Order Information

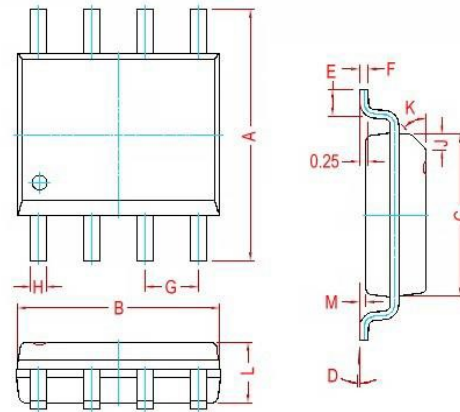
3,000/Reel



### Graphic Symbol

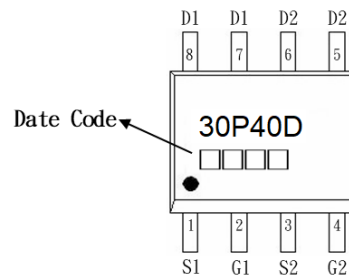


### Package Dimension



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.80	6.20	M	0.10	0.25
B	4.80	5.00	H	0.35	0.51
C	3.80	4.00	L	1.35	1.75
D	0°	8°	J	0.40 Ref.	
E	0.40	0.90	K	45° Ref.	
F	0.19	0.26	G	1.27 Typ.	

### Marking



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#### MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings			
Symbol	Parameter	Value	Units
$V_{DS}$	Drain-Source Voltage	-30	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current <sup>1</sup> ( $T_A=25^\circ\text{C}$ )	-6	A
	Continuous Drain Current <sup>1</sup> ( $T_A=70^\circ\text{C}$ )	-5	A
$I_{DM}$	Pulsed Drain Current <sup>1,2</sup>	-26	A
$I_{AS}$	Single Pulse Avalanche Current, $L=0.1\text{mH}^3$	-30	A
$E_{AS}$	Single Pulse Avalanche Energy, $L=0.1\text{mH}^3$	45	mJ
$P_D$	Power Dissipation <sup>4</sup> ( $T_A=25^\circ\text{C}$ )	2.2	W
$T_J/T_{STG}$	Operating Junction and Storage Temperature	-55 to +150	$^\circ\text{C}$

Thermal Resistance Ratings			
Symbol	Parameter	Maximum	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient <sup>1</sup>	85	$^\circ\text{C/W}$
$R_{\theta JC}$	Maximum Junction-to-Case <sup>1</sup>	25	$^\circ\text{C/W}$

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### Dual P-Channel 30-V (D-S) MOSFET

#### Electrical Characteristics ( $T_J=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$	-1.0	-	-2.5	V
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}$ , $I_D=-250\mu\text{A}$	-30	-	-	V
$g_{fs}$	Forward Transconductance	$V_{DS}=-5\text{V}$ , $I_D=-6\text{A}$	-	17	-	S
$I_{GSS}$	Gate-Source Leakage Current	$V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$	-	-	$\pm 100$	nA
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=-24\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=25^\circ\text{C}$ $V_{DS}=-24\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=55^\circ\text{C}$	-	-	-1 -10	$\mu\text{A}$
$R_{DS(on)}$	Drain-Source On-Resistance <sup>2</sup>	$V_{GS}=-10\text{V}$ , $I_D=-6\text{A}$ $V_{GS}=-4.5\text{V}$ , $I_D=-4\text{A}$	-	-	30 40	m $\Omega$
EAS	Single Pulse Avalanche Energy <sup>5</sup>	$V_{DD}=-25\text{V}$ , $I_{AS}=-6\text{A}$	5	-	-	mJ
$V_{SD}$	Diode Forward Voltage <sup>2</sup>	$I_S=-6\text{A}$ , $V_{GS}=0$ , $T_J=25^\circ\text{C}$	-	-	-1.2	V
$I_S$	Continuous Source Current <sup>1,6</sup>	$V_G=V_D=0\text{V}$ , Force Current	-	-	-6	A
$I_{SM}$	Pulsed Source Current <sup>2,6</sup>		-	-	-26	A

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Dynamic						
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
Q <sub>g</sub>	Total Gate Charge <sup>2</sup>	V <sub>DS</sub> = -15V	--	11.4	--	nC
Q <sub>gs</sub>	Gate-Source Charge	I <sub>D</sub> = -6A	--	4.4	--	
Q <sub>gd</sub>	Gate-Drain Charge	V <sub>GS</sub> = -4.5V	--	4.3	--	
t <sub>d(on)</sub>	Turn-On Delay Time <sup>2</sup>	V <sub>DS</sub> = -15V	--	4.4	--	ns
t <sub>r</sub>	Rise Time	I <sub>D</sub> = -6A	--	14.6	--	
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = -10V	--	40	--	
t <sub>f</sub>	Fall Time	R <sub>G</sub> = 3.3Ω	--	19.3	--	
C <sub>ISS</sub>	Input Capacitance	V <sub>DS</sub> = -15V	--	1220	--	pF
C <sub>OSS</sub>	Output Capacitance	V <sub>GS</sub> = 0V	--	173	--	
C <sub>RSS</sub>	Reverse Transfer Capacitance	f = 1.0MHz	--	142	--	
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> = 0V, V <sub>GS</sub> = 0V, f = 1.0MHz	--	13	--	Ω

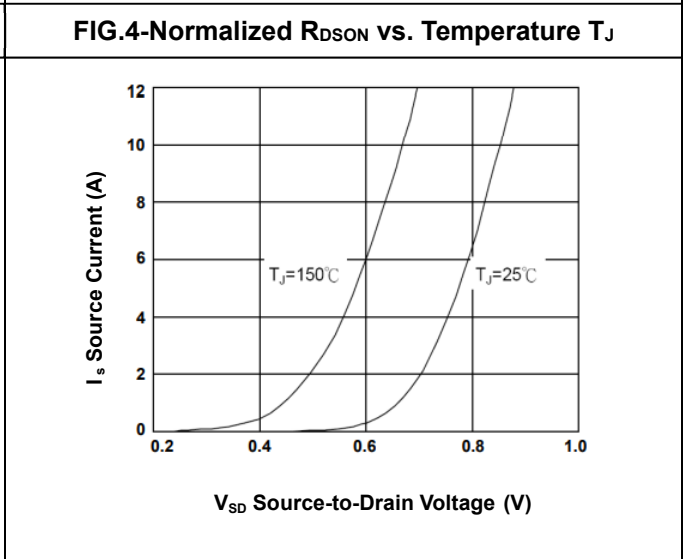
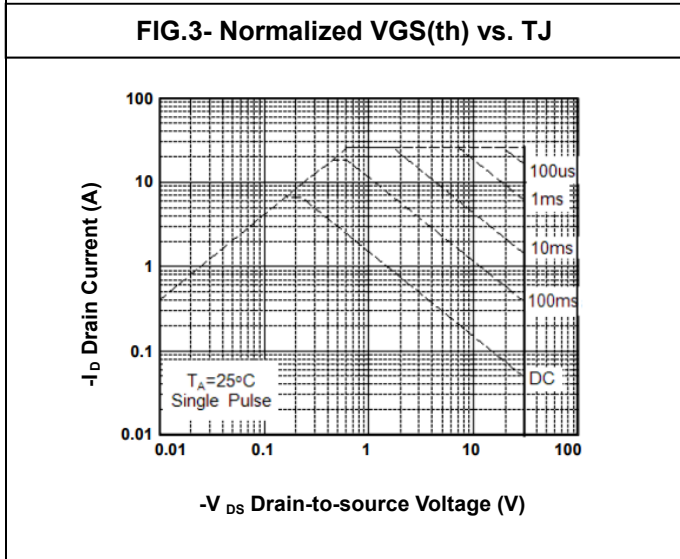
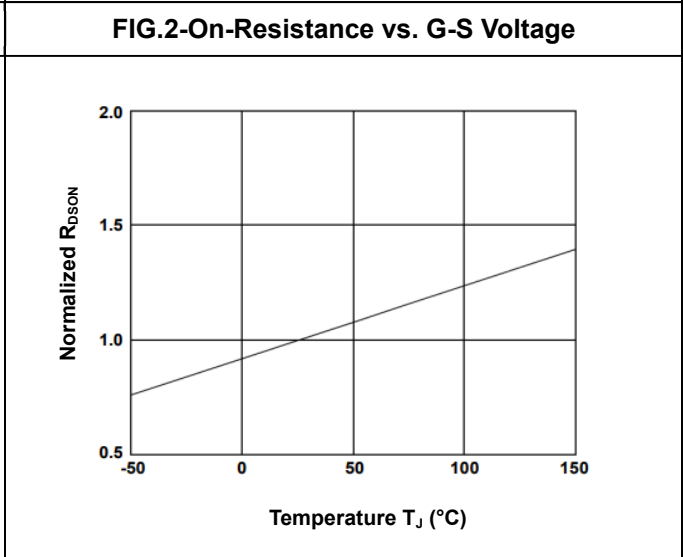
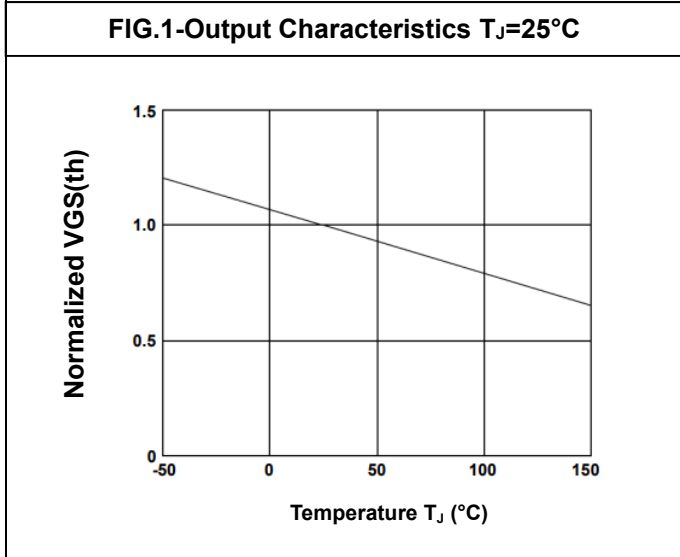
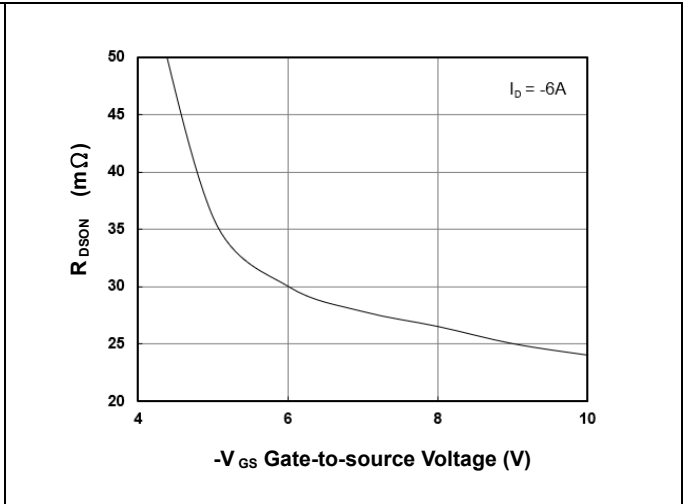
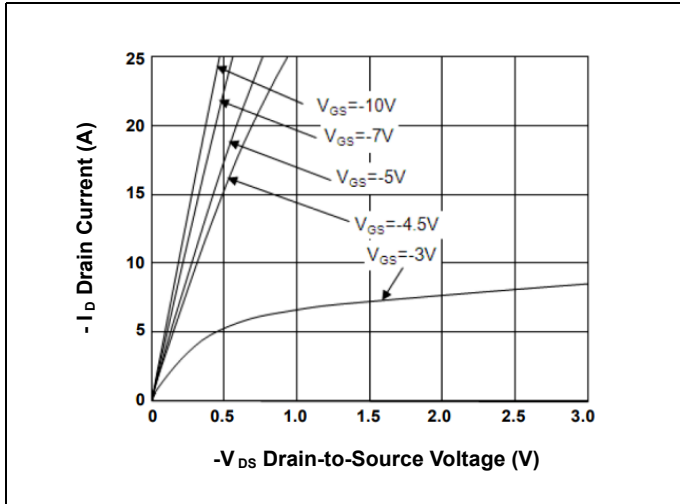
#### Notes

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
3. The EAS data shows maximum rating. The test condition is V<sub>DD</sub> = -25V, V<sub>GS</sub> = -10V, L = 0.1mH, I<sub>AS</sub> = -26A.
4. The power dissipation is limited by 150°C junction temperature.
5. The Min. value is 100% EAS tested guarantee.
6. The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.

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Dual P-Channel 30-V (D-S) MOSFET

- Typical Electrical Characteristics



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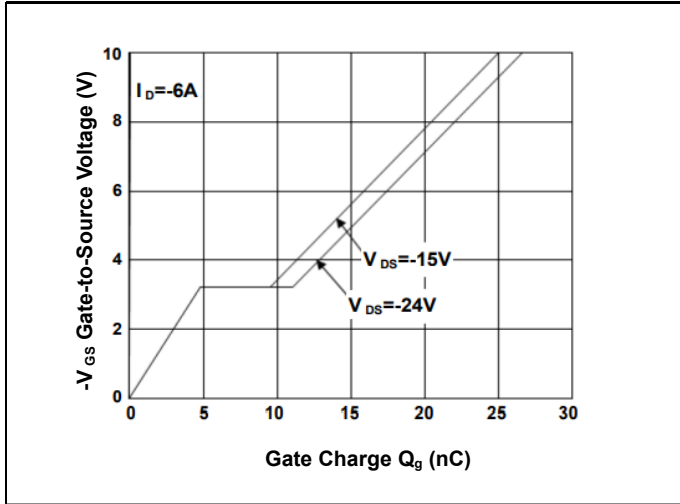


FIG.7- Gate Charge Characteristics

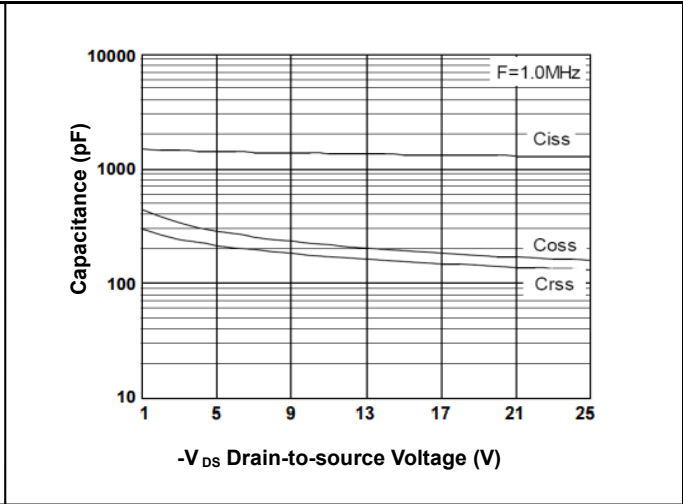


FIG.8- Capacitance Characteristics

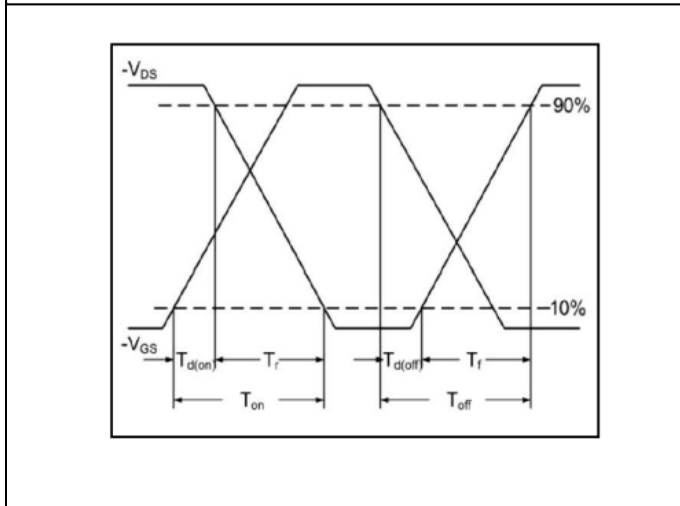


FIG.9- Switching Time Waveform

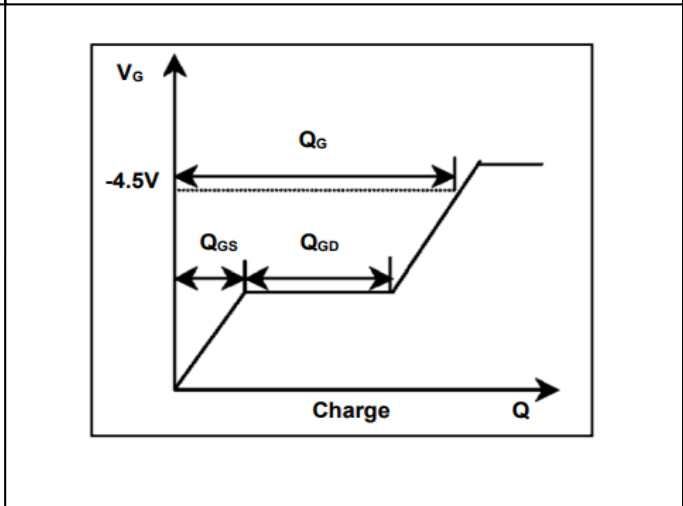


FIG.10- Gate Charge Waveform

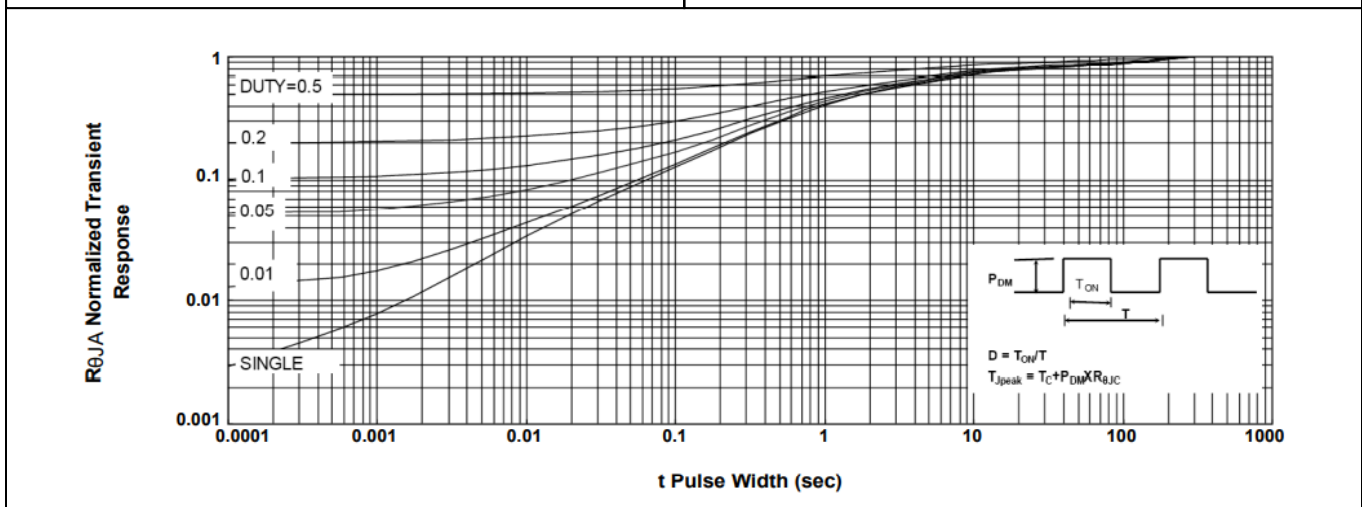


FIG.11- Normalized Maximum Transient Thermal Impedance

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